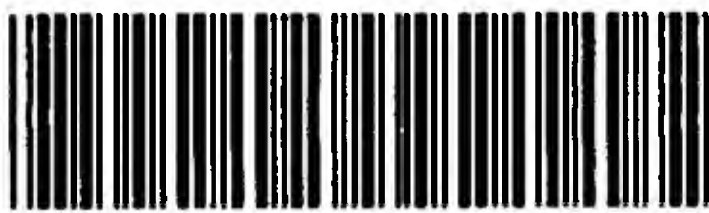


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/631,096	370370	
	Examiner	Art Unit	
	Syed Zaidi	2616	

SEARCHED			
Class	Subclass	Date	Examiner
370	352	7/31/2007	SZ

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (please see search history)	7/31/2007	SZ
Inventor: Henderson et al	7/31/2007	SZ
(IEEE Xplore Database(http://ieeexplore.ieee.org/Xplore/DynWel.jsp))	7/31/2007	SZ
(370/352 370/351 370/463).cccls.	7/31/2007	SZ
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